

Notice of References Cited	Application/Control No. 10/673,507	Applicant(s)/Patent Under Reexamination STRANG, ERIC J.	
	Examiner Akash Saxena	Art Unit 2128	Page 1 of 1

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	"Heat Analysis on Insulated Metal Substrates"; Naomi Yonemura et al; IEEE 1996
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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